

承 認 書

SPECIFICATION FOR APPROVAL

<i>CUSTOMER:</i>	
<i>CUSTOMER P/N</i>	
<i>PART NO:</i>	
<i>DESCRIPTION:</i>	<i>SMD POWER INDUCTORS</i>
<i>PRODUCTS NO:</i>	BCRH104R-150M
<i>PRODUCTS REV:</i>	01
<i>DATE:</i>	2018-6-11

<i>PURCHASER CONFIRMED.</i>		
<i>APPROVAL BY</i>	<i>CHECK BY</i>	<i>DRAWN BY</i>
<i>REMARK</i>		

<i>PROVIDER ENGINEER DEPT.</i>		
<i>APPROVAL BY</i>	<i>CHECK BY</i>	
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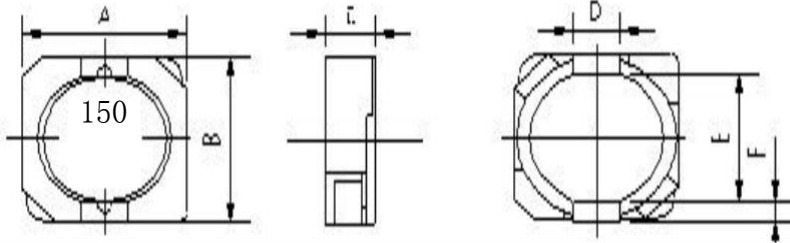
TEST DATA

DIMENSION&ELECTRIC CHARACTER

CUSTOMER:		PART NO. :	
DESCRIPTION:	SMD INDUCTOR	SERIES NO:	BCRH104R-150M

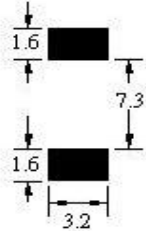
1.MECHANICAL DIMENSION

UNIT : mm



A	10.3MAX
B	10.5MAX
C	4.0MAX
D	3.0±0.1
E	7.7±0.3
F	1.2±0.15
G	
H	
I	

2.RECOMMEND LAND PATTERN DIMENSIONS



3.SPECIFICATIONS

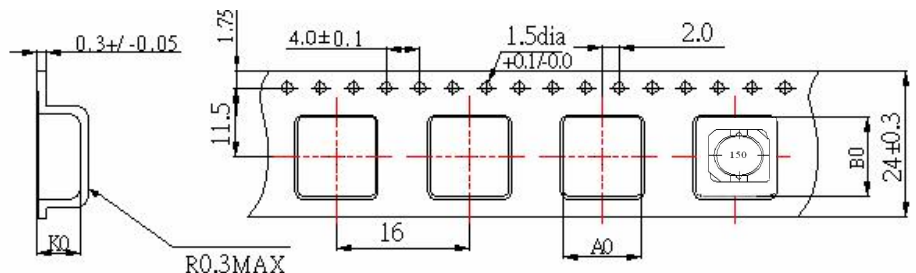
Part Number	L Inductance (uH) @ (0A)	R _{dc} (mOHM)		Heat Rating Current DC Amps. Idc (A)	Saturation Current DC Amps. Idc (A)
		Typical	Max	Typical	Typical
BCRH104R-150M	15.0	44	50	3.1	3.6

- (1). All test data is referenced to 25°C ambient.
- (2). Operating Temperature Rangr-30°C to +100°C.
- (3). DC current(A)that will cause an approoimateΔT of 40°C.
- (4). DC current(A)that will cause Lo to drop approximately 35%.
- (5). The part temperature (ambient+temp rise)should not exeed 100°C under worst case operating conditions. Circuit design, component placement, PWB trace size and thickness, airflow and oter aooting provisions all affset the part temperature part temperature should be verified in the end appliation.

4.PACKAGING INFORMATION

paets are packaged on 13" reels
800 parts per reel.

A0= 10.3mm
B0=10.5mm
K0=4.1mm



APPROVED BY:

CHECKED BY:

DRAWN BY:chenlinli

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TEST DATA FOR PREPRODUCTION SAMPLE

CUSTOMER:			CUSTOMER P/N:				CUSTOMER REV:			TEST DATE:2018-6-11	
PART NAME: SMD INDUCTOR			BC PART NO: BCRH104R-150M				BC REV:			QUANTITY:10PCS	
TEST ITEM	A	B	C	D	E	F	G	H	I	J	K
SPEC.	10.3	10.5	4.0								
	MAX	MAX	MAX								
01	10.00	10.25	3.81								
02	9.99	10.24	3.79								
03	10.00	10.28	3.83								
04	10.03	10.29	3.82								
05	10.19	10.31	3.82								
06	10.18	10.38	3.79								
07	10.05	10.29	3.83								
08	10.06	10.19	3.81								
09	10.18	10.32	3.86								
10	10.09	10.27	3.84								
11											
12											
13											
14											
15											
\bar{X}	10.08	10.28	3.82								
σ	0.075	0.048	0.020								
Cpk	0.99	1.50	2.93								
APPROVED BY			CHECKED BY				PREPARED BY				
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ZHUHAI BAOCHENG ELECTRONICS CO., LTD

TEST DATA FOR PREPRODUCTION SAMPLE

CUSTOMER:		CUSTOMER P/N:		CUSTOMER REV:	TEST DATE:2018-6-11	
PART NAME: SMD INDUCTOR		BC PART NO: BCRH104R-150M		BC REV:	QUANTITY:10PCS	
TEST ITEM	L (0A)	L (3.6A) /L (0A) 100%	DCR (S-F)			
TEST CONDITION	100KHZ 0.25V					
SPEC.	15uH +20%	= 65% AT DC 3.6A	50m Ω			
01	14.36	73%	43.66			
02	14.22	78%	44.52			
03	15.84	80%	45.78			
04	14.67	78%	44.23			
05	15.06	75%	43.43			
06	14.05	89%	42.89			
07	15.85	80%	42.56			
08	14.82	78%	44.83			
09	14.75	79%	45.18			
10	14.32	73%	43.81			
11						
12						
13						
14						
15						
\bar{X}	14.79		44.09			
σ	0.600		0.963			
Cpk	2.39		2.05			

1. TEST INSTRUMENTS:

- HP-4284A METER
 HP-4285A METER
 HP-4191A METER
 VR116+VR7220 METER
 CH-3200 METER
 CH-310 METER
 CH-3305 METER
 CD1068+CD1320 METER
 VR113+VR712+R712 METER
 WK3260B+WK3265B METER
 VR562 METER
 CH-502B DCR METER

2. CONDITION

TEMPERATURE: 25°C
 HUMIDITY: 65%RH

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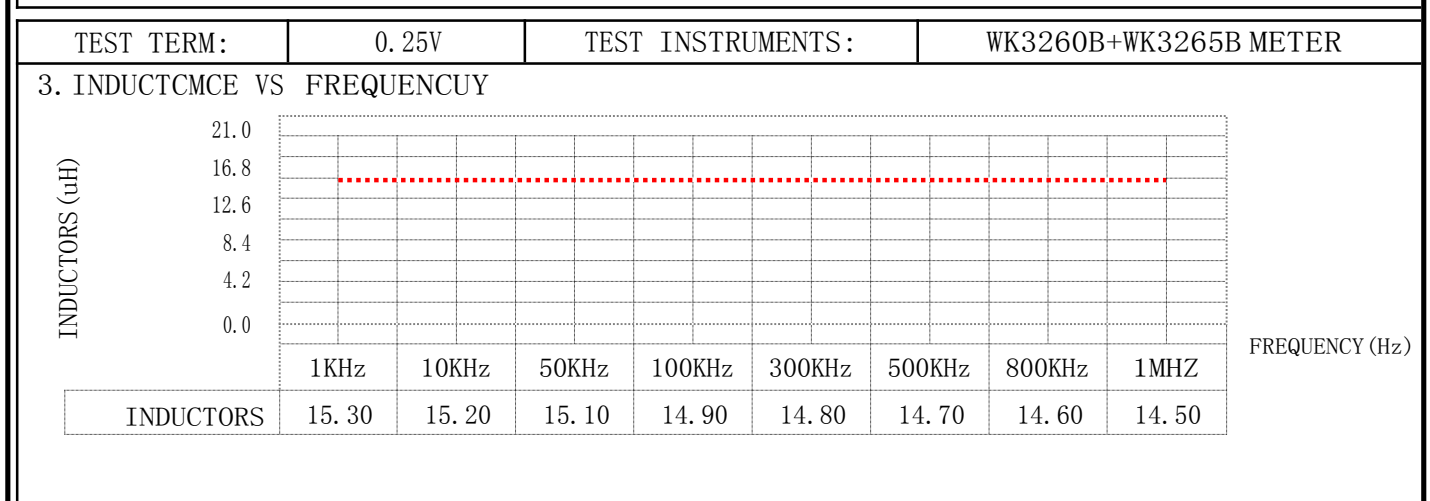
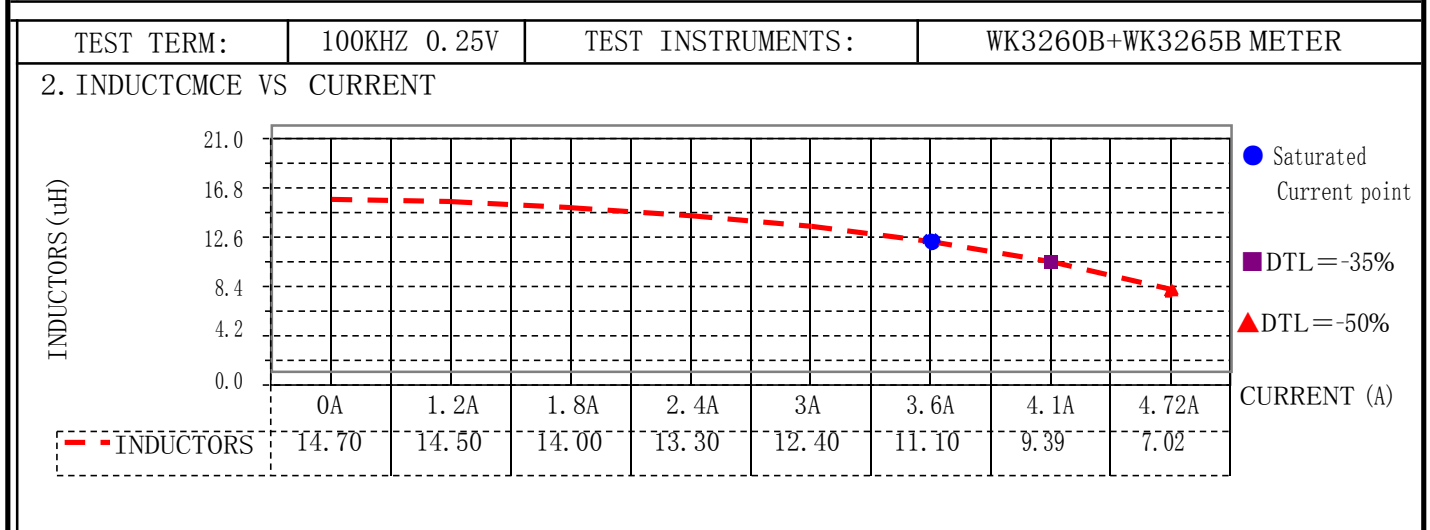
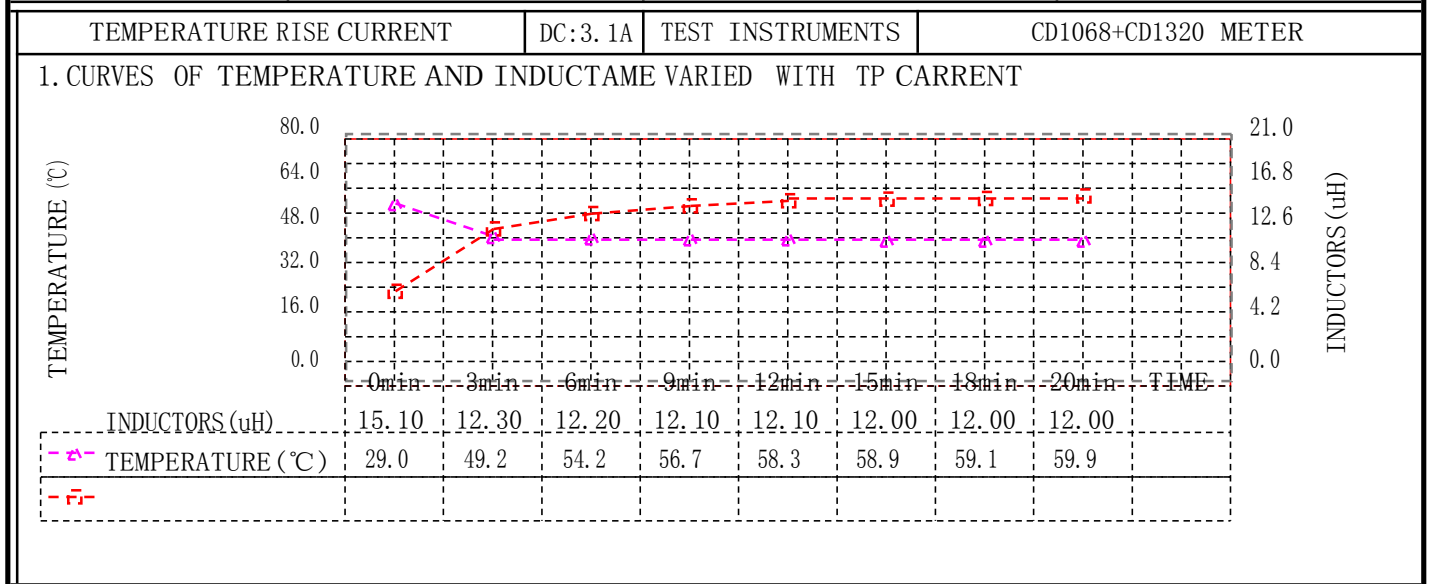
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ELECTRONICS CHARACTER TEST CHART

CUSTOMER :		CUSTOMER P/N:	TEST DATE:2018-6-11
PART NAME :	SMD INDUCTOR	BC P/N: BCRH104R-150M	SAMPLE CO:

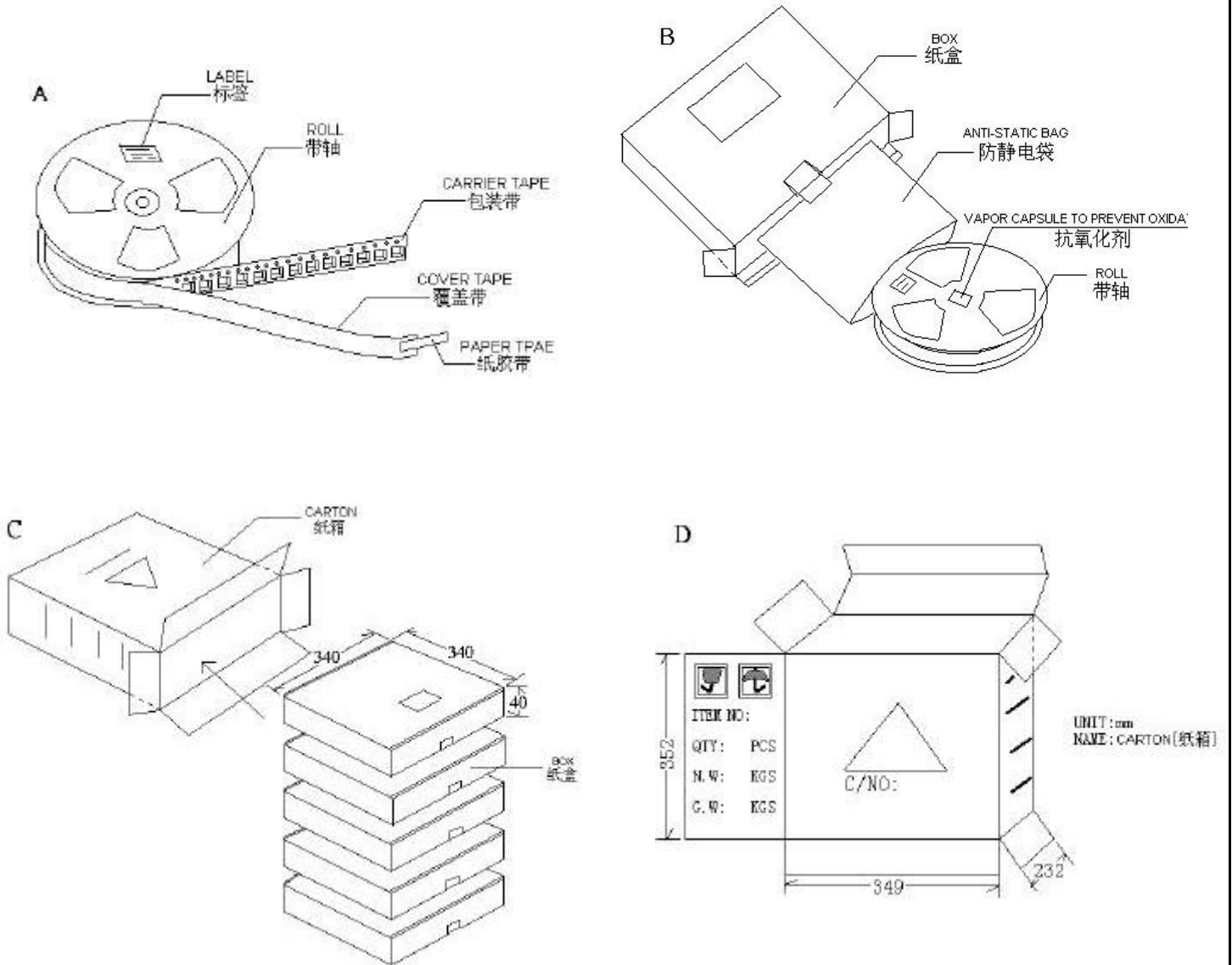


1. TEST CONDITION
 TEMPERATURE: 25°C
 HUMIDITY: ≤ 65% RH

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PACKAGE STANDARD

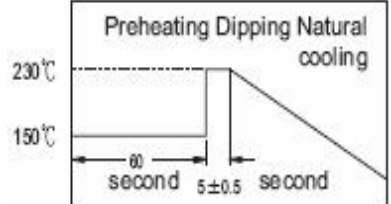
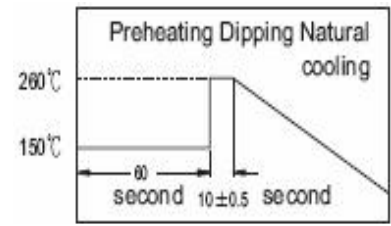
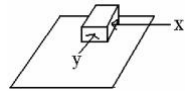
PART NO. BCRH104R SERIES



NO	A	B	C
MODEL	φ 330*24	SMD-BC	BC-10
QUANTITY	800PCS	800PCS	4000PCS

■ GENERAL CHARACTERISTICS

P.1

Operation Temperature	-30°C to +100°C (Includes temperature when the coil is heated)
External Appearance	On visual inspection, the coil has no external defects.
Solder Ability Test	<p>1. More than 90% of terminal electrode should be covered with solder.</p> <ul style="list-style-type: none"> ● After fluxing, component shall be dipped in a melted. ● Solder: bath at 230°C±5°C for 5±0.5 seconds. 
Solder Heat Resistance	<p>1. Components should have not evidence of electrical and mechanical damage. 2. Inductance: within±10% of initial value. 3. Impedance: within±30% of initial value.</p> <ul style="list-style-type: none"> ● Preheat: 150±5°C 60seconds. ● Solder temperature: 260±5°C. ● Flux: rosin. ● Dip time: 10±0.5seconds. 
Terminal Strength	<p>After soldering of X,Y withstanding at below conditions .The terminal should not Peel off. (Refer to figure at below)</p> <ul style="list-style-type: none"> ● 5N:60sec. BC Series, BCB Series, BCDB Series, BCEI Series BCEP Series, BCH Series, BCMD Series, BCMS Series, BCPF Series, BCPS Series BCR Series, BCRH Series, BCRHB Series, BCX Series, BCIHP Series, BCLQ72, BCRM135, BCPH73, BCC5D23, BCHP1210. ● 10N:10sec. BC73, BC75, BC4020FH, BC74B. ● 15N:10sec. BC104, BC105, BC105B, BC108, BC5022FH. ● 20N:10sec. BCR125B. 
Insulating Resistance	Over 100MO at 100V D.C. between coil and core.
Dielectric Strength	No dielectric breakdown at 100V D.C. for 1 minute between coil and core.
Vibration Resistance	Inductance deviation within ±3% after vibration for 1 hour. In each of three orientations at Sweep vibration (10~55~10HZ) with 1.5mmP-P amplitudes.
Shock Resistance	Inductance deviation within ±3% after being dropped once with 981m/s ² (100G) shock Attitude upon a rubber block method shock testing machine, in three different orientations

■ Application Notice/Handling

1. Storage Conditions

To maintain the solder ability of terminal electrodes:

- (1) Temperature and humidity conditions: less than 40°C and 70% RH.
- (2) Products should be used within 6 months.
- (3) The packaging material should be kept where no chlorine or sulfur exists in the air.

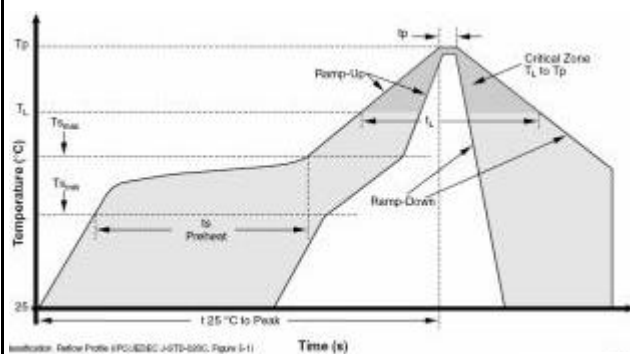
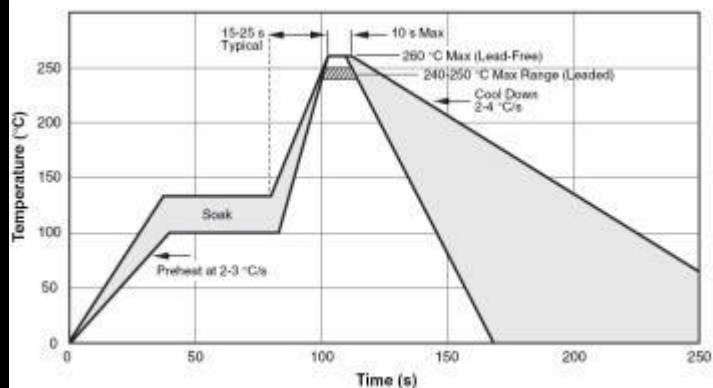
2. Handling

- (1) Do not touch the electrodes (soldering terminals) with fingers as this may lead to deterioration of solderability.
- (2) The use of tweezers or vacuum pick-ups is strongly recommended for individual components.
- (3) Bulk handling should ensure that abrasion and mechanical shock are minimized.

■ THE CONDITION OF REFLOW(RECOMMENDATION)

TYPICAL WAVE SOLDER PROFILE FOR LEADED AND LEAD-FREE THROUGH-HOLE PACKAGES

TYPICAL IR REFLOW PROFILE FOR LEADED AND LEAD-FREE SURFACE MOUNT PACKAGES



IPC/JEDEC J-STD-020C, Figure 5-1

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average Ramp-Up Rate (Ts _{max} to Tp)	3 °C/second max.	3 °C/second max.
Preheat		
± Temperature Min (Ts _{min})	100 °C	150 °C
± Temperature Max (Ts _{max})	150 °C	200 °C
± Time (ts _{min} to ts _{max})	60-120 seconds	60-180 seconds
Time maintained above:		
± Temperature (T _l)	183 °C	217 °C
± Time (t _l)	60-150 seconds	60-150 seconds
Peak/Classification Temperature (Tp)	See Table 4.1	See Table 4.2
Time within 5 °C of actual Peak Temperature (tp)	10-30 seconds	20-40 seconds
Ramp-Down Rate	6 °C/second max.	6 °C/second max.
Time 25 °C to Peak Temperature	6 minutes max.	8 minutes max.

Table 4. Classification Reflow Profiles (per IPC/JEDEC J-STD-020C, Table 5.2)

Note 1: All temperatures refer to topside of the package, measured on the package body surface.

Package Thickness	Volume mm ³ <350	Volume mm ³ ≥350
<2.5 mm	240 +0/-5 °C	225 +0/-5 °C
≥2.5 mm	225 +0/-5 °C	225 +0/-5 °C

Table 5. SnPb Eutectic Process – Package Peak Reflow Temperatures (per IPC/JEDEC J-STD-020C, Table 4.1)

Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
<1.6 mm	260 + 0 °C *	260 + 0 °C *	260 + 0 °C *
1.6 mm - 2.5 mm	260 + 0 °C *	250 + 0 °C *	245 + 0 °C *
≥2.5 mm	250 + 0 °C *	245 + 0 °C *	245 + 0 °C *

* Tolerance: Process compatibility is up to and including the stated classification temperature (this means Peak reflow temperature + 0 °C. For example 260 °C + 0 °C) at the rated MSL level.

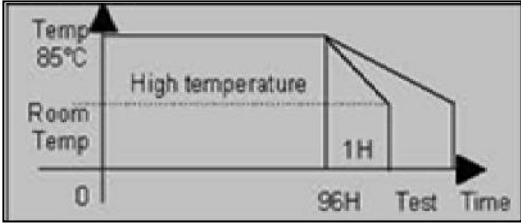
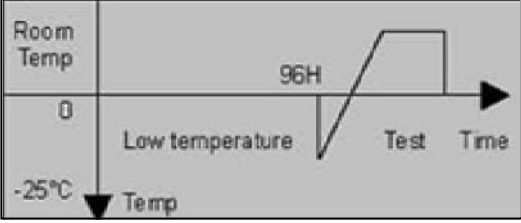
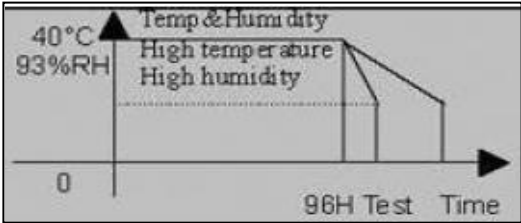
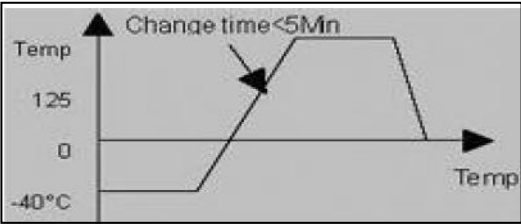
Table 6. Pb-free Process – Package Classification Reflow Temperatures (per IPC/JEDEC J-STD-020C, Table 4.2)

Note 1: The profiling tolerance is + 0 °C, -X °C (based on machine variation capability) whatever is required to control the profile process but at no time will it exceed -5 °C. Process compatibility at the peak reflow profile temperatures as defined in Table 4.2.

Note 2: Package volume excludes external terminals (balls, bumps, lands, leads) and/or nonintegral heat sinks.

Note 3: The maximum component temperature reached during reflow depends on package thickness and volume. The use of convection reflow processes reduces the thermal gradients between packages. However, thermal gradients due to differences in thermal mass of SMD packages may still exist.

Note 4: Components intended for use in a "lead-free" assembly process shall be evaluated using the "lead-free" classification temperatures and profiles defined in Tables 4.1, 4.2 and 5.2 whether or not lead free.

TEST	Required Characteristics	Test Method/Condition
<p>High Temperature Storage Test</p> <p>Reference documents: MIL-STD-202G Method 108A</p>	<p>1.No case deformation or change in appearance 2. $\Delta L/L \leq 10\%$ 3. $\Delta Q/Q \leq 30\%$ 4. $\Delta DCR/DCR \leq 10\%$</p>	 <p>Temperature: $85^{\circ}\text{C} \pm 2^{\circ}\text{C}$ Time: 96 ± 2 hours. Tested not less than 1 hour, nor more than 2 hours at room.</p>
<p>Low Temperature Storage Test</p> <p>Reference documents: IEC 68-2-1A 6.1 6.2</p>	<p>1.No case deformation or change in appearance. 2. $\Delta L/L \leq 10\%$ 3. $\Delta Q/Q \leq 30\%$ 4. $\Delta DCR/DCR \leq 10\%$</p>	 <p>Temperature: $-25^{\circ}\text{C} \pm 2^{\circ}\text{C}$ Time: 96 ± 2 hours. Tested not less than 1 hour, nor more than 2 hours at room.</p>
<p>Humidity Test</p> <p>Reference documents: MIL-STD-202G Method 103B</p>	<p>1.No case deformation or change in appearance. 2. $\Delta L/L \leq 10\%$ 3. $\Delta Q/Q \leq 30\%$ 4. $\Delta DCR/DCR \leq 10\%$</p>	 <ol style="list-style-type: none"> 1. Dry oven at a temperature of $40^{\circ}\text{C} \pm 5^{\circ}\text{C}$ for 24 hours. 2. Measurements At the end of this period 3. Exposure: Temperature: $40^{\circ}\text{C} \pm 5^{\circ}\text{C}$. Humidity: 93 ± 2 hours. 4. Tested while the the chamber. 5. Tested not less than 1 hour. Nor more than 2 hours at room temperature.
<p>Thermal Shock Test</p> <p>Reference documents: MIL-STD-202G Method 107G</p>	<p>1. No case deformation or change in appearance. 2. $\Delta L/L \leq 10\%$ 3. $\Delta Q/Q \leq 30\%$ 4. $\Delta DCR/DCR \leq 10\%$ For T: weight $\leq 28\text{g}$: 15Min $28\text{g} \leq \text{weight} \leq 136\text{g}$: 30Min</p>	 <p>First – 40°C for T time, last 125°C T time as 1 cycle. Go through 20 cycles.</p>

Application Notice/Handling

- (4) Temperature and humidity conditions : less than 40°C and 70% RH.
- (5) Products should be used within 6 months.
- (6) The packaging material should be kept where no chlorine or sulfur exists in the air.
- (7) Do not touch the electrodes (soldering terminals) with fingers as this may lead to deterioration of solder ability
- (8) The use of tweezers or vacuum pick-ups is strongly recommended for individual components.
- (9) Bulk handling should ensure that abrasion and mechanical shock are minimized.

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